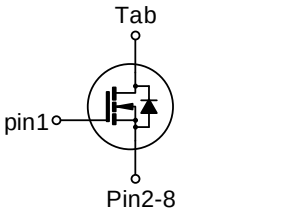
320A, 100V N-CHANNEL MOSFET

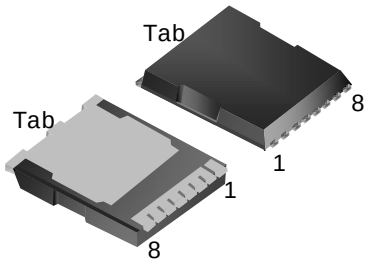
DESCRIPTION

SVGP101R5NL is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan's LVMOS technology. The improved process and cell structure have been especially tailored to minimize on-state resistance, provide superior switching performance.

This device is widely used in power management for UPS and Inverter Systems.



Pin1.Gate Tab2.Drain pin2-8.Source



TOLL-8L

FEATURES

- 320A, 100V, $R_{DS(on)(typ.)}$=1.1mΩ@V_{GS}=10V
- Low gate charge
- Low Crss
- Fast switching
- Extreme dv/dt rated
- 100% avalanche tested
- Pb-free lead plating
- RoHS compliant

KEY PERFORMANCE PARAMETERS

Characteristics	Ratings	Unit
V_{DS}	100	V
$V_{GS(th)}$	2.2~3.8	V
$R_{DS(on),max}$	1.5	mΩ
I_D	320	A
$Q_{g.typ}$	238	nC

ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing Type
SVGP101R5NLTR	TOLL-8L	P101R5N	Halogen free	Tape&reel

ABSOLUTE MAXIMUM RATINGS (UNLESS OTHERWISE NOTED, T_J=25°C)

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Drain-source Voltage	V_{DS}	--	--	--	100	V
Gate-source Voltage	V_{GS}	--	-20	--	20	V
Drain Current (Note 1)	I_D	T_C=25°C	--	--	320	A
		T_C=100°C	--	--	210	A
Drain Current Pulsed (Note 2)	I_{DM}	T_C=25°C	--	--	1280	A
Power Dissipation (Note 3)	P_D	T_C=25°C	--	--	321	W
Single Pulsed Avalanche Energy	E_{AS}	L=0.1mH, V_{DD}=80V, R_G=25Ω, starting temperature T_J=25°C	--	--	756	mJ
Single Pulsed Avalanche Current	I_{AS}	--	--	--	123	A
Operation Junction Temperature Range	T_J	--	-55	--	150	°C
Storage Temperature Range	T_{stg}	--	-55	--	150	°C

THERMAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Thermal Resistance, Junction-case, Bottom	$R_{\theta JC}$	--	--	--	0.39	°C/W
Thermal Resistance, Junction-ambient	$R_{\theta JA}$	--	--	--	45	°C/W
Soldering Temperature (SMD)	T_{sold}	Reflow soldering: 10±1 sec, 3times	--	--	260	°C

ELECTRICAL CHARACTERISTICS (UNLESS OTHERWISE NOTED, T_J=25°C)

Static characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Drain-source Breakdown Voltage	BV_{DSS}	V_{GS}=0V, I_D=250μA	100	--	--	V
Drain-source Leakage Current	I_{DSS}	V_{DS}=100V, V_{GS}=0V, T_J=25°C	--	--	1.0	μA
		V_{DS}=100V, V_{GS}=0V, T_J=125°C	--	9.0	--	μA
Gate-source Leakage Current	I_{GSS}	V_{GS}=±20V, V_{DS}=0V	--	--	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V_{GS}=V_{DS}, I_D=250μA	2.2	--	3.8	V
Static Drain-source On State Resistance	$R_{DS(on)}$	V_{GS}=10V, I_D=150A	--	1.1	1.5	mΩ
		V_{GS}=6.0V, I_D=75A	--	1.4	2.0	mΩ
Gate Resistance	R_g	f=1MHz	--	2.8	--	Ω

Dynamic characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Input Capacitance	C_{iss}	f=1MHz, V_{GS}=0V, V_{DS}=50V	--	17694	--	pF
Output Capacitance	C_{oss}		--	2681	--	
Reverse Transfer Capacitance	C_{rss}		--	66	--	
Turn-on Delay Time	$t_{d(on)}$	V_{DD}=50V, V_{GS}=10V, R_G=1.8Ω, I_D=100A (Notes 4,5)	--	47	--	ns
Turn-on Rise Time	t_r		--	85	--	
Turn-off Delay Time	$t_{d(off)}$		--	139	--	
Turn-off Fall Time	t_f		--	78	--	
Total Gate Charge	Q_g	V_{DD}=50V, V_{GS}=10V, I_D=100A (Notes 4,5)	--	239	--	nC
Gate-source Charge	Q_{gs}		--	85	--	
Gate-drain Charge	Q_{gd}		--	40	--	
Gate-plateau Voltage	$V_{plateau}$		--	4.9	--	V

Reverse diode characteristics

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I_S	Integral Reverse P-N Junction	--	--	320	A
Diode pulse current	$I_{S,pulse}$	Diode in the MOSFET	--	--	1280	
Diode Forward Voltage	V_{SD}	I_S=100A, V_{GS}=0V	--	--	1.4	V
Reverse Recovery Time	T_{rr}	I_S=100A, V_{GS}=0V, V_R=80V	--	111	--	ns
Reverse Recovery Charge	Q_{rr}	dI_F/dt=100A/μs (Note 4)	--	299	--	nC

Notes:

1. The rated value only refers to the maximum absolute value at the case temperature of 25°C in the specification. If the case temperature is higher than 25°C, it should be derated according to the actual environmental conditions;
2. Pulse time 5μs;
3. The dissipation power will change with temperature, derating above 25°C: 2.56W/°C;
4. Pulse Test: Pulse width ≤300μs, Duty cycle≤2%;
5. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

Figure 1. Output Characteristics

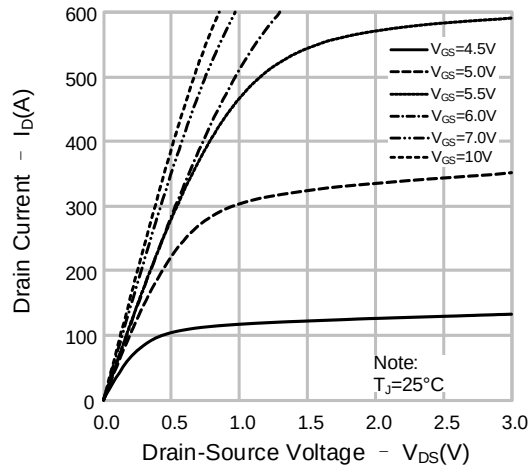


Figure 2. Transfer Characteristics

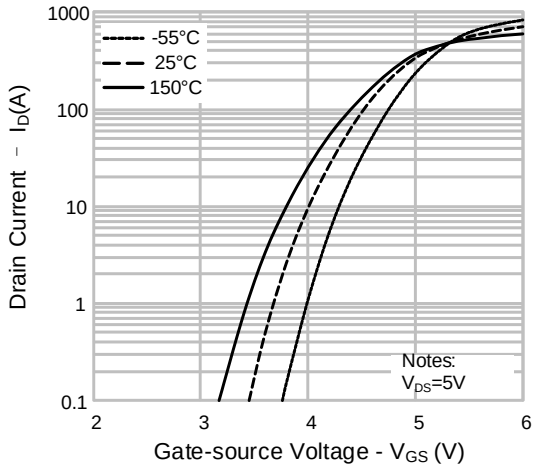


Figure 3. On-resistance vs. Drain Current

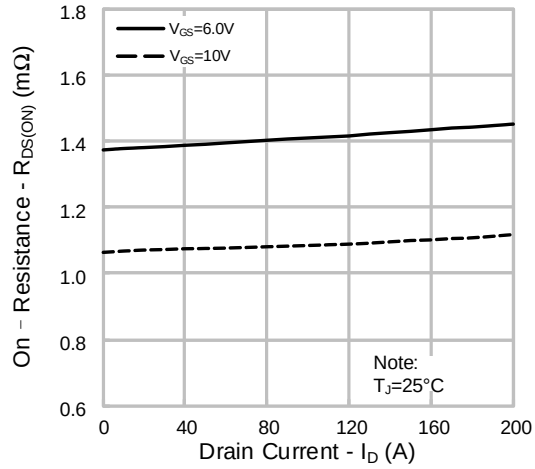


Figure 4. On-resistance vs. Gate-Source Voltage

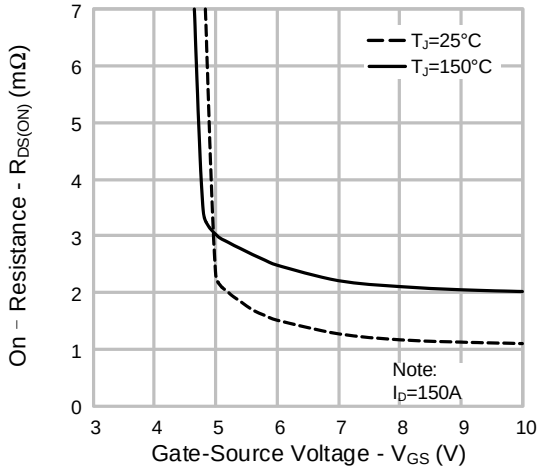


Figure 5. Turn-on Voltage vs. Temperature Characteristics

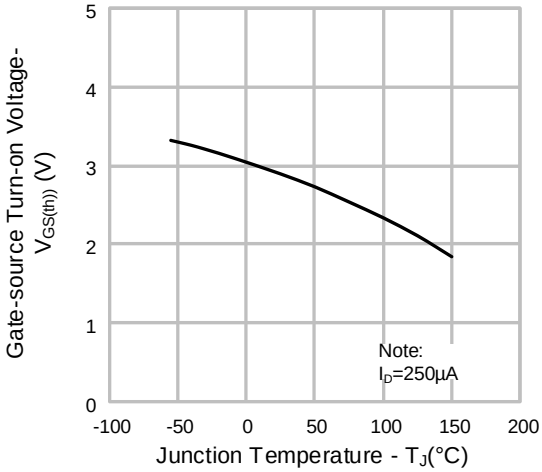
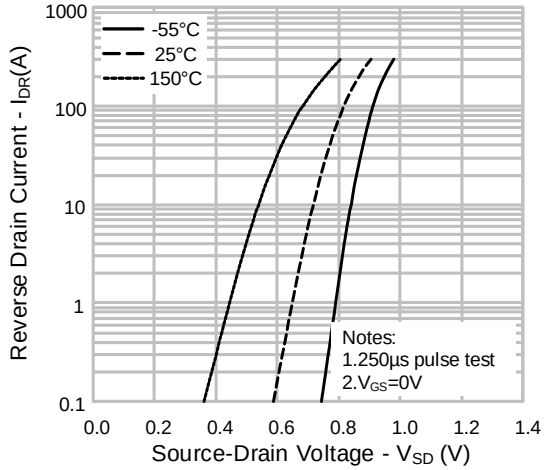


Figure 6. Body Diode Forward Voltage Variation vs. Source Current and Temperature



TYPICAL CHARACTERISTICS (CONTINUED)

Figure 7. Capacitance Characteristics

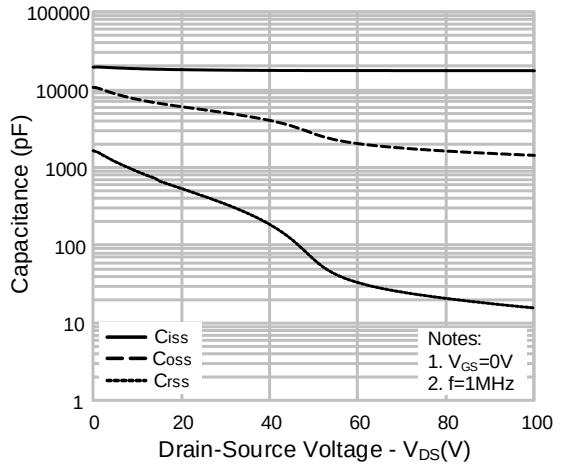


Figure 8. Gate Charge Characteristics

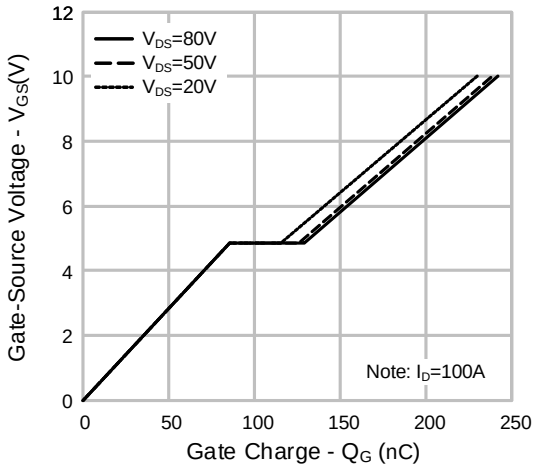


Figure 9. Breakdown Voltage Variation vs. Temperature

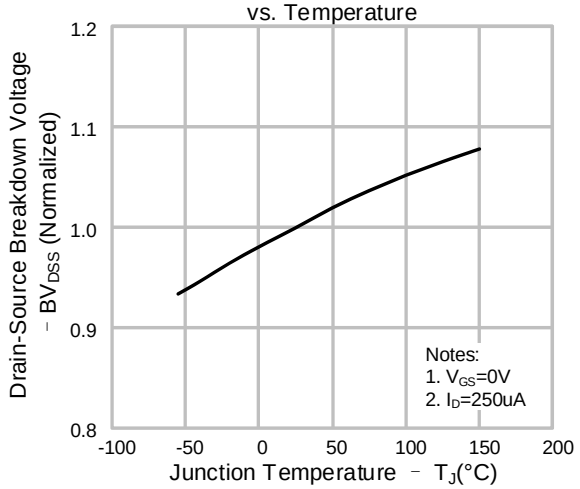


Figure 10. On-resistance Variation vs. Temperature

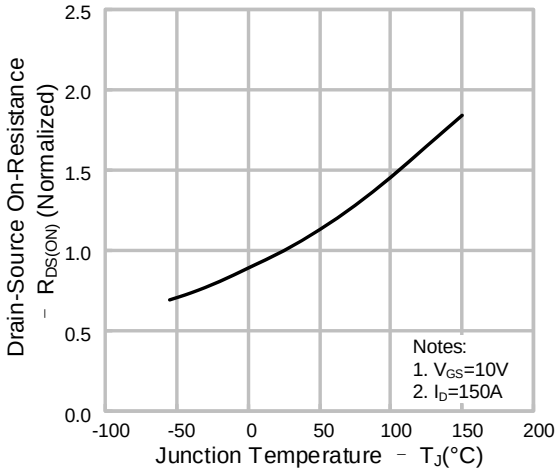


Figure 11. Max. Safe Operating Area

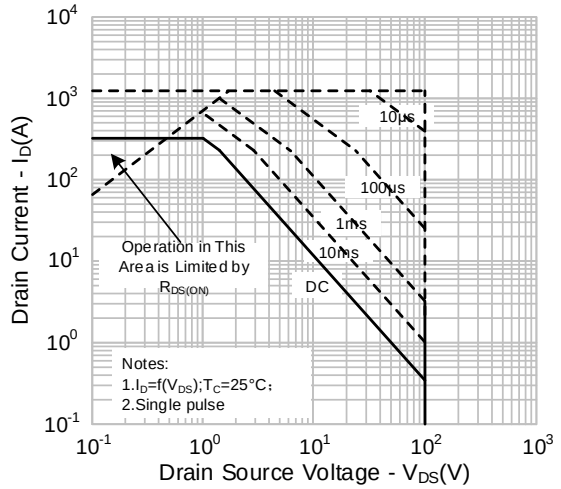
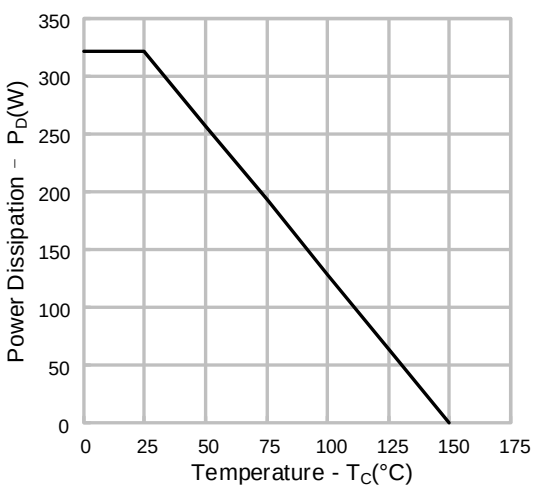


Figure 12. Power Dissipation vs. Temperature



TYPICAL CHARACTERISTICS (CONTINUED)

Figure 13. Drain Current vs. Case Temperature

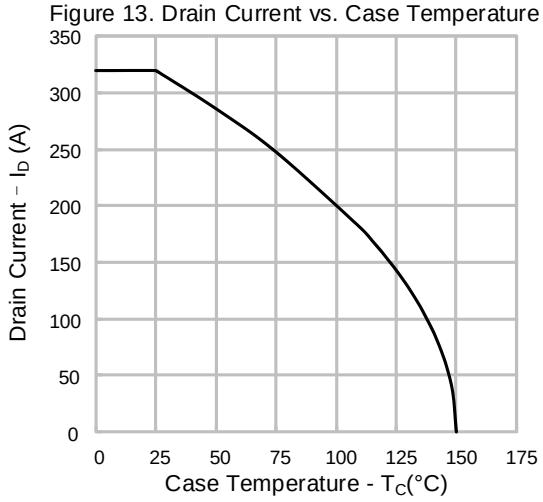
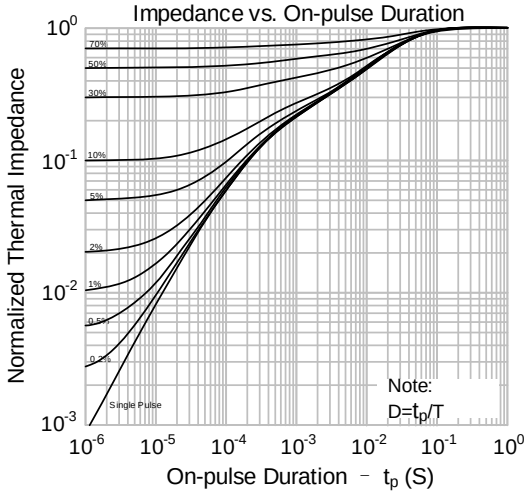
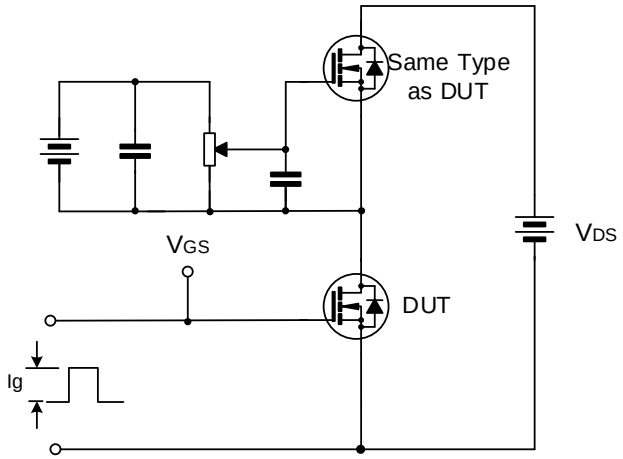


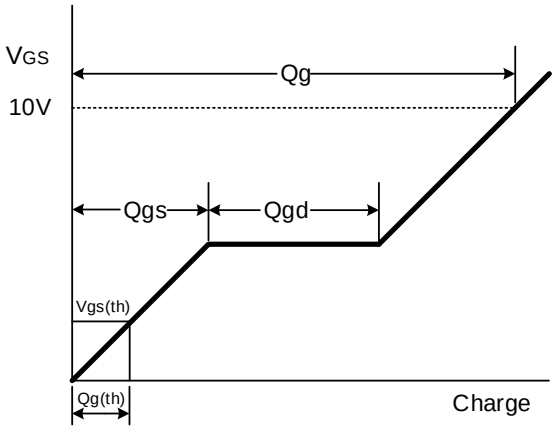
Figure 14. Transient Thermal Impedance vs. On-pulse Duration



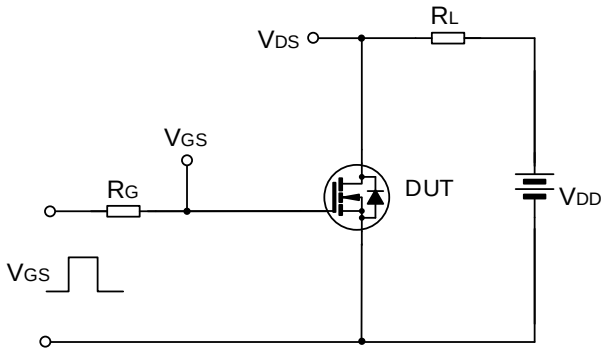
TYPICAL TEST CIRCUIT

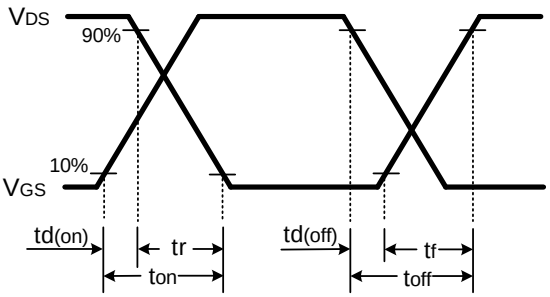
Gate Charge Test Circuit & Waveform



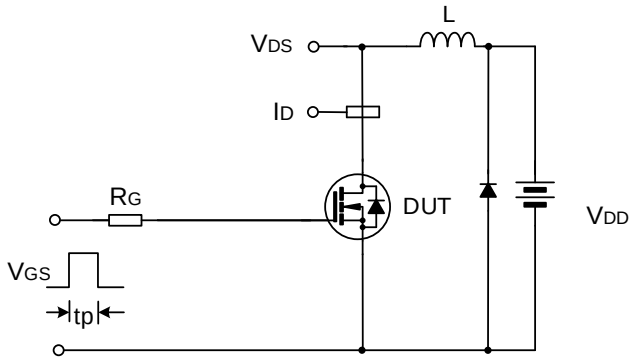


Resistive Switching Test Circuit & Waveform

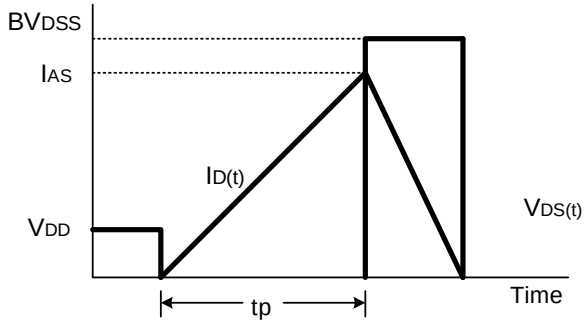




Unclamped Inductive Switching Test Circuit & Waveform

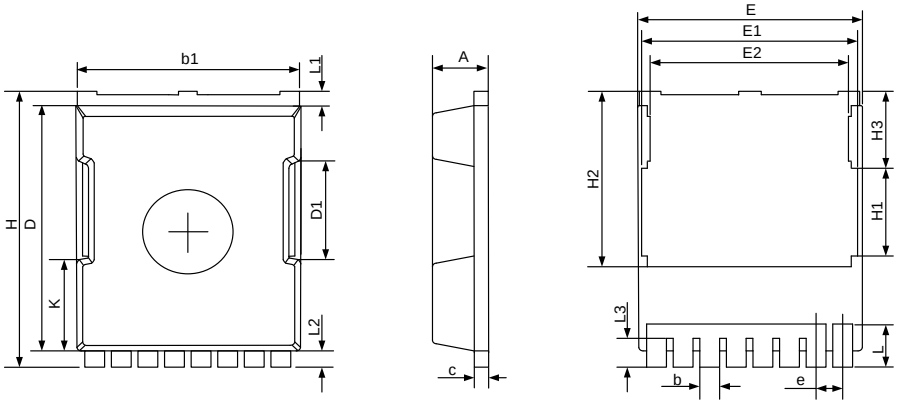


$$E_{AS} = \frac{1}{2} L I_{AS}^2$$



PACKAGE OUTLINE

TOLL-8L **UNIT: mm**



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	2.20	2.30	2.40
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
c	0.40	0.50	0.60
D	10.28	10.38	10.48
D1	3.15	3.30	3.45
E	9.70	9.90	10.10
E1	9.30	9.50	9.70
E2	8.35	8.50	8.65
e	1.20 BSC		
H	11.48	11.73	11.88
H1	3.16	3.26	3.36
H2	7.20	7.35	7.50
K	4.03	4.18	4.33
L	1.60	1.85	2.10
L1	0.55	0.70	0.85
L2	0.45	0.60	0.75
L3	1.05	1.20	1.30

MOS DEVICES OPERATE NOTES:

Electrostatic charges may exist in many things. Please take following preventive measures to prevent effectively the MOS electric circuit as a result of the damage which is caused by discharge:

- The operator must put on wrist strap which should be earthed to against electrostatic.
- Equipment cases should be earthed.
- All tools used during assembly, including soldering tools and solder baths, must be earthed.
- MOS devices should be packed in antistatic/conductive containers for transportation.

Important notice:

1. Silan reserves the right to make changes of this instruction without notice.
2. Customers should obtain the latest relevant information when purchasing and should verify whether such information is latest and complete. Please read this instruction and application manual and related materials carefully before using products, including the circuit operation precautions, etc.
3. It is neither tested nor verified in accordance with AEC-Q series standards testing or application requirements. Silan does not give any warranties as to the suitability of the Silan's product for any specific use. The design intent, design definition and design of the product are not intended for application (the application stated in this instruction includes use, etc.) in transportation equipment, medical equipment, life-saving equipment, aerospace equipment, non-civil equipment or non-civil use, etc. (the equipment stated in this instruction includes systems, devices, etc., all referred to as equipment).The product should not be used in any equipment or system whose manufacture, use or sale is prohibited under any applicable laws or regulations("unintended use"). If the product is used for unintended use, therefore the full risks of such products application are borne by the customer and Silan assumes no liability for the product used for the unintended use. If the customer intends to use the Silan's product in a application where malfunction or failure can be reasonably be expected to result in personal injury, or serious property, or environment damage, the customer shall make adequate assessment, testing and verification, and Silan shall not be liable for such applications.
4. The application of the product described in this instruction, the application manual of the product and related materials is for illustrative purposes only, and Silan makes no warranty that such application can be used directly without further testing, verification or modification. Silan is not responsible for any assistance in product application or customers' product design. Customer shall be responsible for the application of Silan's products and the design, manufacture and use of customers' products using Silan's products (in this document, "use products", "apply Silan's products", "product application" and "customers' products using Silan's products" are synonymous). It is the sole responsibility of the customer to take the following actions: 1) Verify and determine whether Silan's products are suitable for the customers' applications and customers' products; 2) All applicable standards of the customers' industry shall be complied with and fully tested and verified when applying Silan's product or using Silan's product to develop and design customers' products; 3) Although Silan is constantly committed to improve product's quality and reliability, semiconductor products have possibility to malfunction or fail in various application environments. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for customers' products using Silan's product to minimize risks and avoid situations in which a malfunction or failure could cause bodily injury or damage to property; 4) When using the products, please do not exceed the maximum rating of the products, Stress above one or more limiting values will cause damage to the product and the equipment or affect the reliability to the equipment (customers' product); 5) Ensure customers' product using Silan's product are designed, manufactured and used in full compliance with all applicable standards, safety standards and other requirements of the customers' industry. The parameters stated in this instruction may and do vary in different applications, actual performance may vary over time. Customers must use the products within their effective static storage period, please contact Silan sales or Silan customer service support and sales management department if there is any questions about the effective static storage period, Silan does not assume any responsibility if the product has exceeded the static storage period when it is used.
5. Do not disassemble, reverse-engineer, alter, modify, decompile or copy product, without Silan's prior written consent.
6. Please identify Silan's trademark when purchasing our product. Please contact us if there is any question. Our products are not sold through TAOBAO or any other third-party e-commerce platforms. If customers purchase from such platforms, please contact us in writing before purchasing to confirm whether the product is authentic and original from Silan.
7. Please use and apply product in compliance with all applicable laws and regulations, including but not limited to trade control regulations etc. The product is civil electronic product, please do not use it in non-civil fields.
8. Product promotion is endless, our company will wholeheartedly provide customers with better products!
9. Website: http: //www.silan.com.cn

Part No.:	SVGP101R5NL	Document Type:	Datasheet
Copyright:	HANGZHOU SILAN MICROELECTRONICS CO.,LTD	Website:	http: //www.silan.com.cn

Rev.: 1.0

Revision History:

1. First release